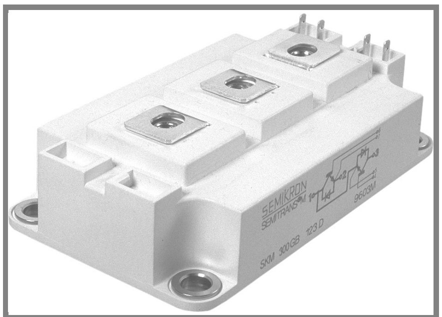
SKM 300GB126D



SEMITRANS™ 3

Trench IGBT Module

SKM 300GB126D

Preliminary Data

Features

- Homogeneous Si
- Trench = Trenchgate technology
- V_{CEsat} with positive temperature coefficient
- High short circuit capability, self limiting to 6 x I_c

Typical Applications

- Electronic welders
- AC inverter drives
- UPS

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Absolute Maximum Ratings		T_c = 25 °C, unless otherwise specified	
Symbol	**Conditions**	**Values**	**Units**
IGBT			
V_{CES}		1200	V
I_C	T_c = 25 (80) °C	310 (200)	A
I_{CRM}	T_c = 25 (80) °C, t_p = 1 ms	620 (400)	A
V_{GES}		± 20	V
T_{vj}, (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C
V_{isol}	AC, 1 min.	4000	V
Inverse diode			
I_F	T_c = 25 (80) °C	250 (170)	A
I_{FRM}	T_c = 25 (80) °C, t_p = 1 ms	620 (400)	A
I_{FSM}	t_p = 10 ms; sin.; T_j = 150 °C		A

Characteristics			T_c = 25 °C, unless otherwise specified		
Symbol	**Conditions**	**min.**	**typ.**	**max.**	**Units**
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$, I_C = 8 mA	5	5,8	6,5	V
I_{CES}	V_{GE} = 0, $V_{CE} = V_{CES}$, T_j = 25 (125) °C		0,1	0,3	mA
$V_{CE(TO)}$	T_j = 25 (125) °C		1 (0,9)	1,2 (1,1)	V
r_{CE}	V_{GE} = 15 V, T_j = 25 (125) °C		3,5 (5,5)	4,7 (6,8)	mΩ
$V_{CE(sat)}$	I_C = 200 A, V_{GE} = 15 V, chip level		1,7 (2)	2,15 (2,45)	V
C_{ies}	under following conditions		15		nF
C_{oes}	V_{GE} = 0, V_{CE} = 25 V, f = 1 MHz		1,2		nF
C_{res}			1,1		nF
L_{CE}				20	nH
$R_{CC'+EE'}$	res., terminal-chip T_c= 25 (125) °C		0,35 (0,5)		mΩ
$t_{d(on)}$	V_{CC} = 600 V, I_C = 200 A		280		ns
t_r	$R_{Gon} = R_{Goff}$ = 1,5 Ω, T_j = 125 °C		37		ns
$t_{d(off)}$	V_{GE} = ± 15 V		560		ns
t_f			100		ns
E_{on} (E_{off})			21 (33)		mJ
Inverse diode					
$V_F = V_{EC}$	I_F = 200 A; V_{GE} = 0 V; T_j = 25 (125) °C		1,6 (1,6)	1,8 (1,8)	V
$V_{(TO)}$	T_j = 25 (125) °C		1 (0,8)	1,1	V
r_T	T_j = 25 (125) °C		3 (3,9)	3,3	mΩ
I_{RRM}	I_F = 200 A; T_j = 125 ( ) °C		290		A
Q_{rr}	di/dt = 6200 A/µs		44		µC
E_{rr}	V_{GE} = 0 V		18		mJ
Thermal characteristics					
$R_{th(j-c)}$	per IGBT			0,12	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,25	K/W
$R_{th(c-s)}$	per module			0,038	K/W
Mechanical data					
M_s	to heatsink M6	3		5	Nm
M_t	to terminals M6	2,5		5	Nm
w				325	g

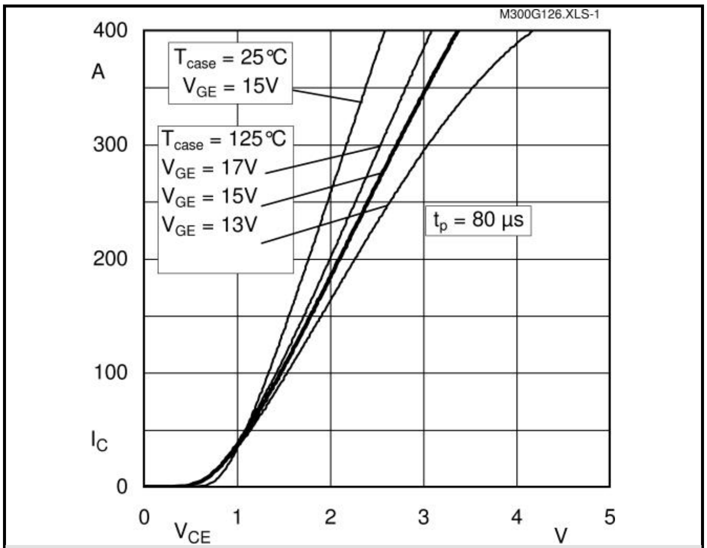


Fig. 1 Typ. output characteristic, inclusive $R_{CC'+ EE'}$

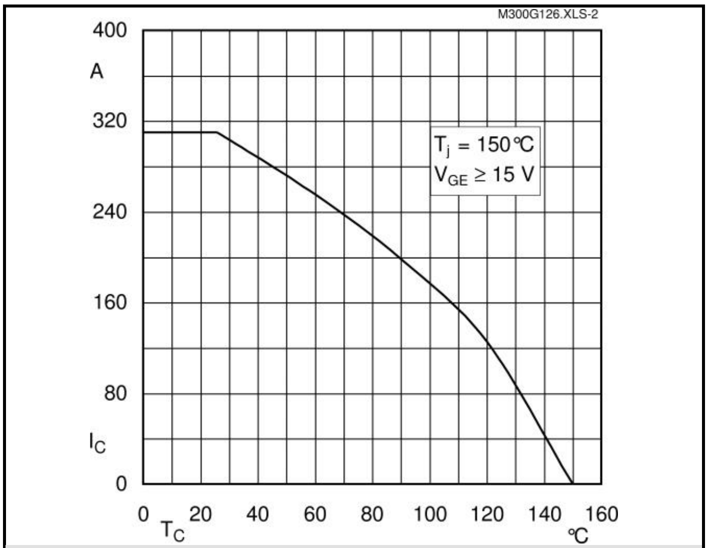


Fig. 2 Rated current vs. temperature I_C = f (T_C)

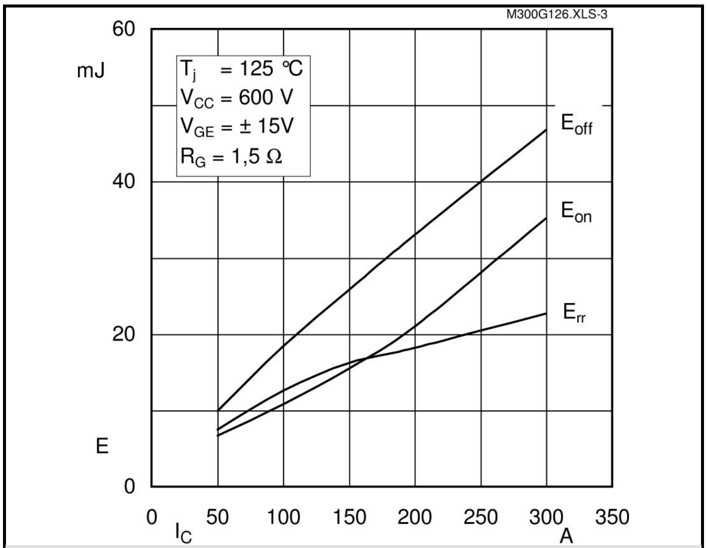


Fig. 3 Typ. turn-on /-off energy = f (I_C)

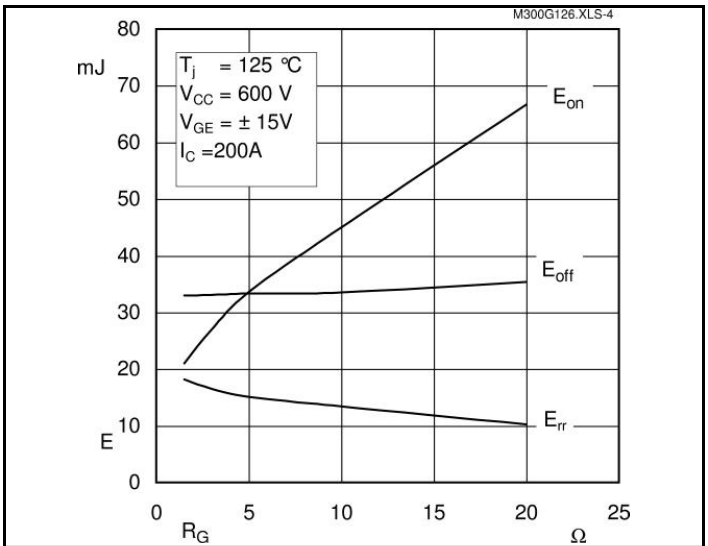


Fig. 4 Typ. turn-on /-off energy = f (R_G)

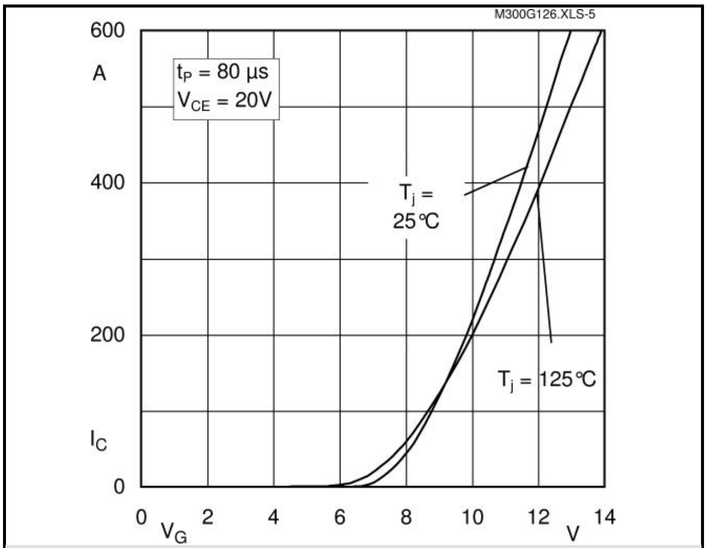


Fig. 5 Typ. transfer characteristic

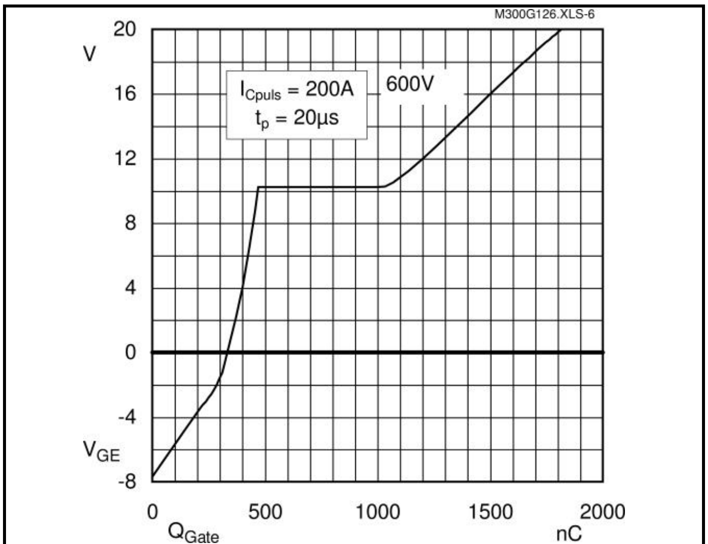


Fig. 6 Typ. gate charge characteristic

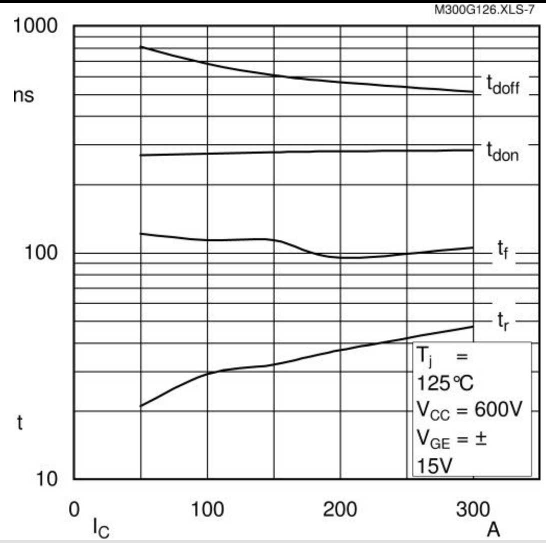


Fig. 7 Typ. switching times vs. I_C

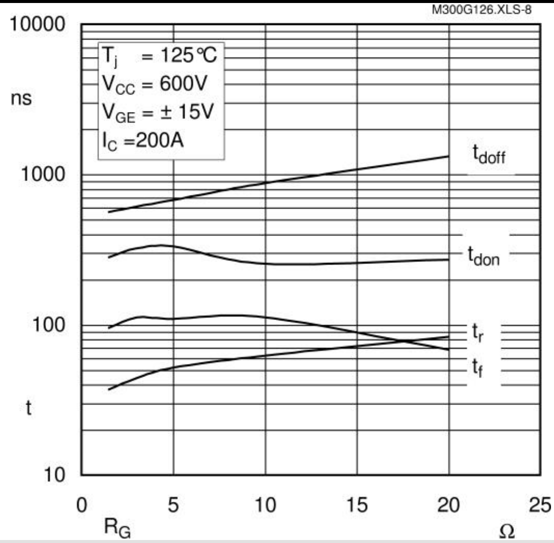


Fig. 8 Typ. switching times vs. gate resistor R_G

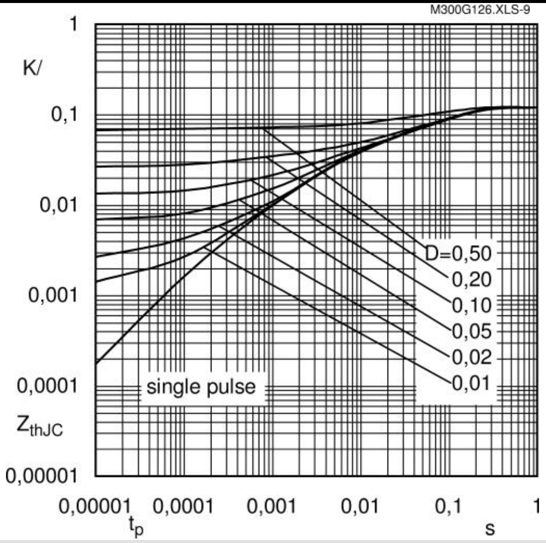


Fig. 9 Transient thermal impedance of IGBT

$Z_{thp(j-c)} = f(t_p)$; $D = t_p/t_c = t_p{*}f$

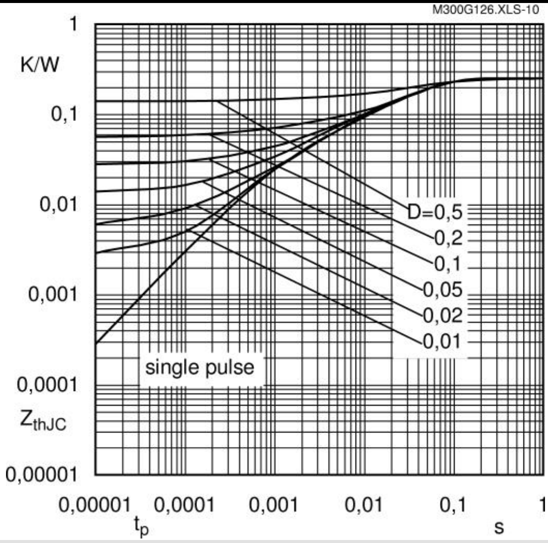


Fig. 10 Transient thermal impedance of FWD

$Z_{thp(j-c)} = f(t_p)$; $D = t_p/t_c = t_p{*}f$

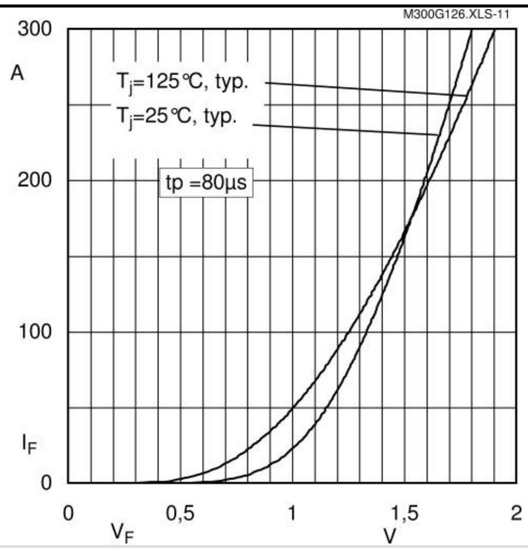


Fig. 11 CAL diode forward characteristic

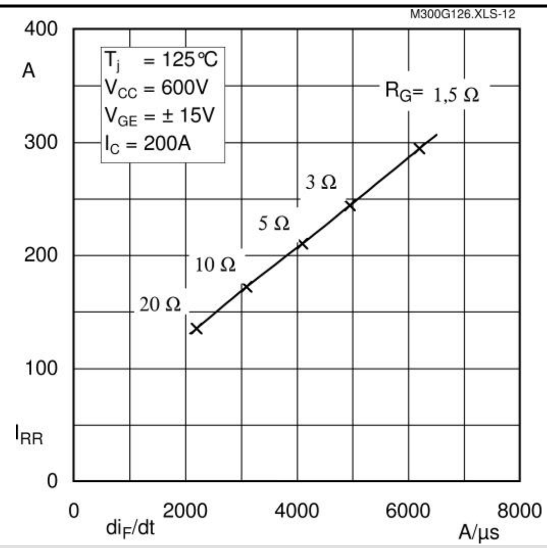


Fig. 12 Typ. CAL diode peak reverse recovery current

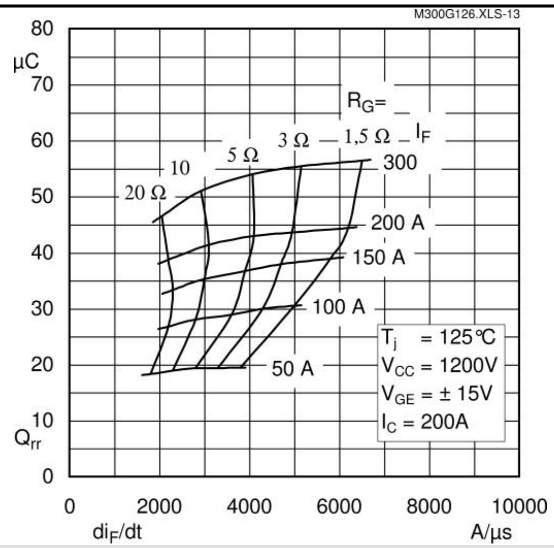
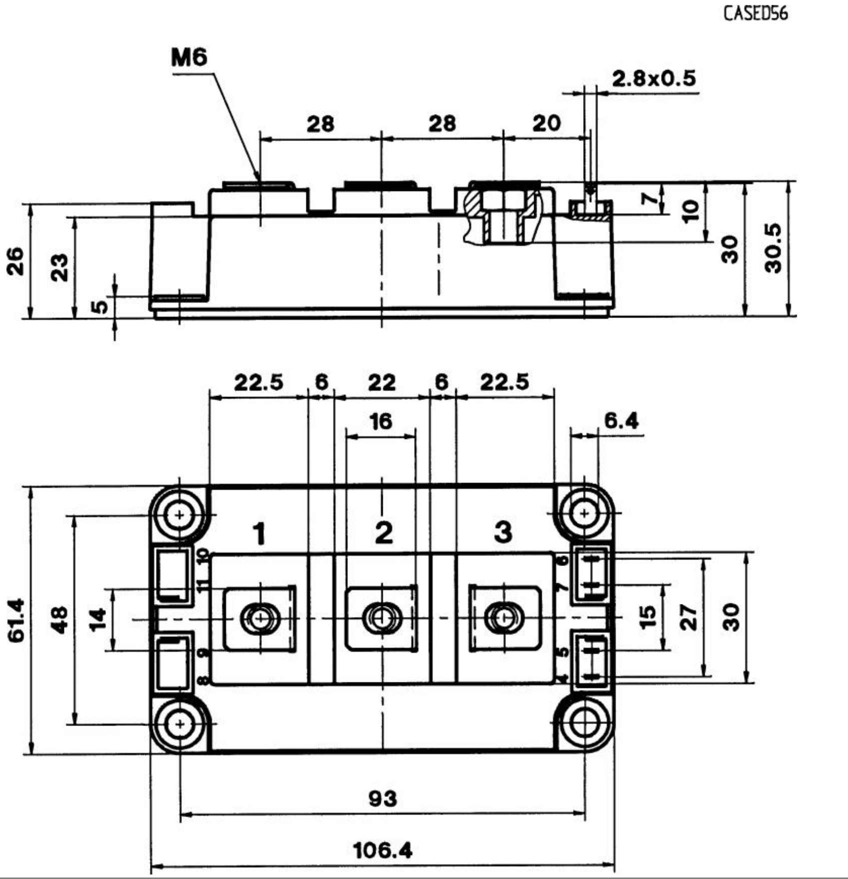


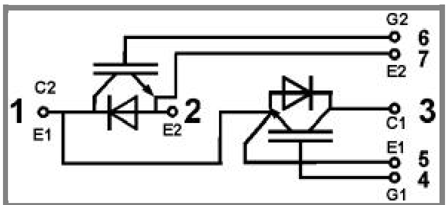
Fig. 13 Typ. CAL diode recovered charge

UL Recognized
File no. E 63 532

Dimensions in mm



Case D 56



GB Case D 56

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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